

**Comments on the Use of Avalanche
Photodiodes in the Electromagnetic
Calorimeter of a Tau-Charm Factory**

J. Swain, with Y. Musienko, S. Nicol, and S. Reucroft
Northeastern University, Boston, Mass.

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Introduction

Avalanche photodiodes are relatively new devices, about to be used in a large-scale experiment (CMS) for the first time: 61,200 PbWO_4 crystals to read out (earlier proposed for TEXAS and SDC fibre trackers).

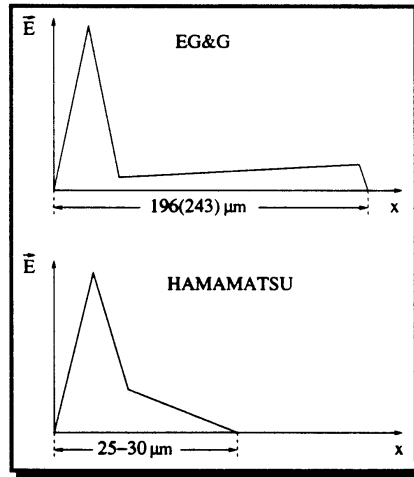
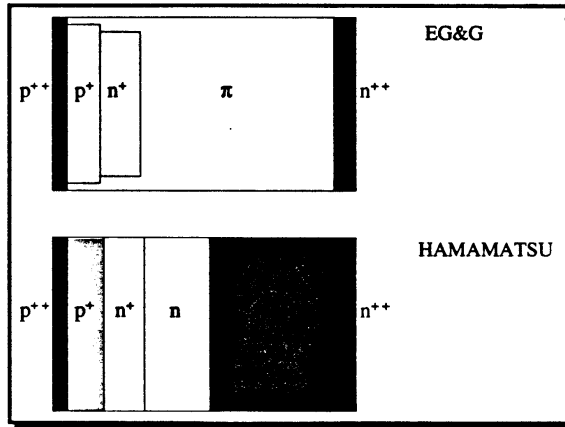
High electric field leads to avalanche multiplication following electron-hole pair creation due to absorbed photons.

- Advantages:
 - Much recent R&D
 - Several manufacturers (EG&G, Hamamatsu, RMD)
 - (can be) Radiation hard and able to work in large \vec{B} fields
 - Provide gain of ~ 100 easily with bias ~ 400 V
 - Very high QE (~ 80 %)
 - Small and mechanically robust
 - Fast (low capacitance); Gain \times BW \approx 100 GHz easy

Introduction

- **Drawbacks:**
 - **Gain is voltage-sensitive** ($1/M \text{ dM/dV} \sim \text{a few \%}/V$ typical)
 - **Gain is temperature-sensitive** ($1/M \text{ dM/dT} \sim 3\%/^{\circ}\text{C}$ typical)
 - **Noisier than PMT's** (at least at normal temperatures); fluctuations; excess noise factor
 - **Maximum size** $\sim 5 \text{ mm} \times 5 \text{ mm}$ (but can use pairs)
 - **Care needed with "Nuclear counter effect"**

Device Structures



Device Characteristics

Diode	Area [mm ²]	Bias at Gain 50 [V]	I_{bulk} [nA]	C [pF]	Q.E. at 480 nm [%]
BC-16	19.6	183.5	6	140	63
EG&G-15	25	365	9.2	25	78
EG&G-3	25	420	16.2	20	83
S3590-01	100	40($M=1$)	0.6	69	65

Table 1: Parameters of APD's and PIN photodiode measured at 20 C before irradiation.

Diode	Bias at Gain 50 [V]	I_{bulk} [μA]	L_{eff} [μm]	Q.E. at 480 nm [%]	neutron fluence [n/cm ²]
BC-16	183.5	13	4.5 ± 0.5	51	2.33 × 10 ¹³
EG&G-15	374	30	9 ± 1	78	2.33 × 10 ¹³
EG&G-3	450	39	11 ± 1	83	2.33 × 10 ¹³
S3590-01	5($M=1$)	13	170 ± 10	63	2.17 × 10 ¹³

Table 2: Parameters of APD's and p-i-n photodiode (last line) measured at 20 C after irradiation.

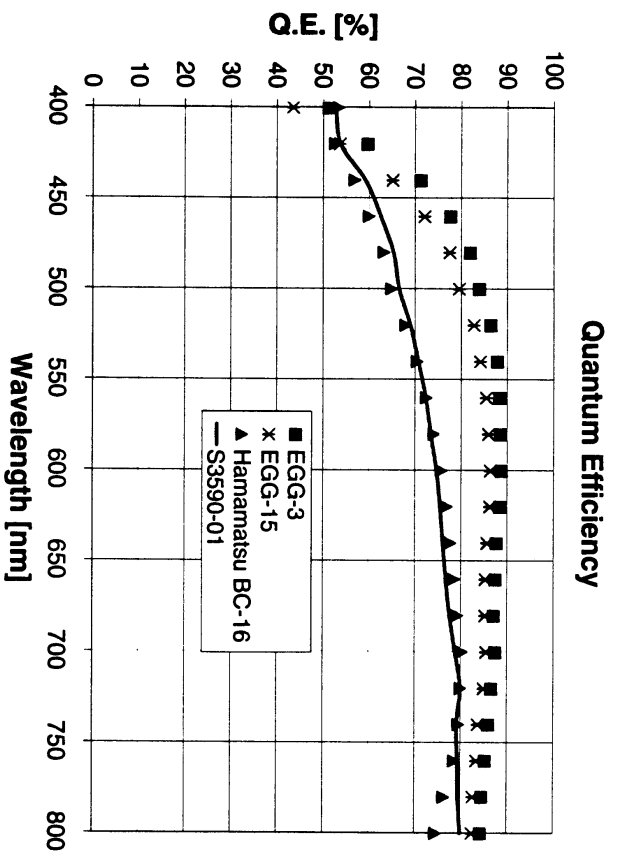


Figure 1: Measured quantum efficiency versus wavelength for APD's and S3590-01 photodiode.

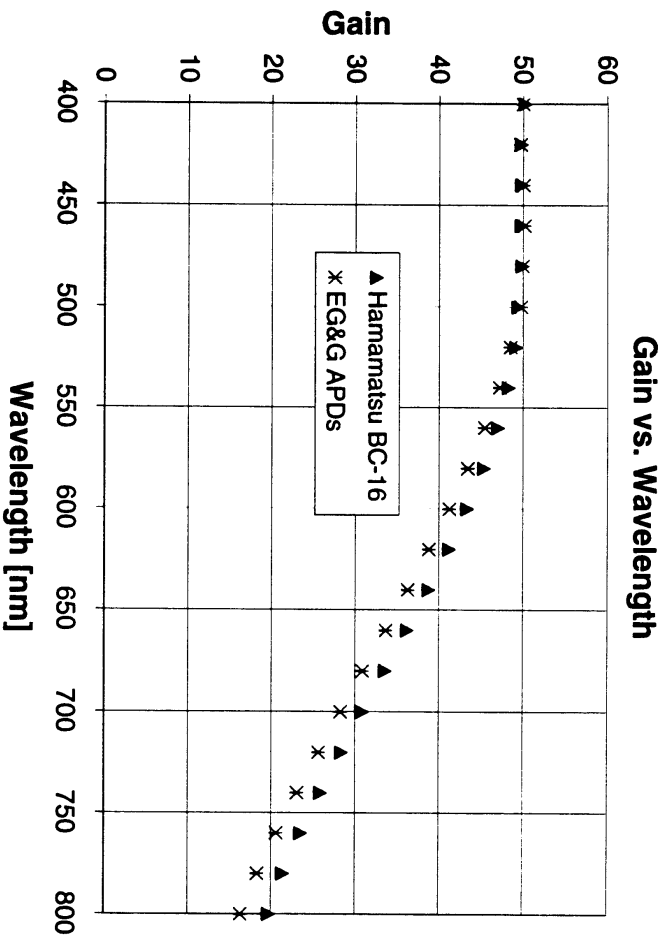


Figure 2: Gain as a function of wavelength for Hamamatsu and EG&G APD's.

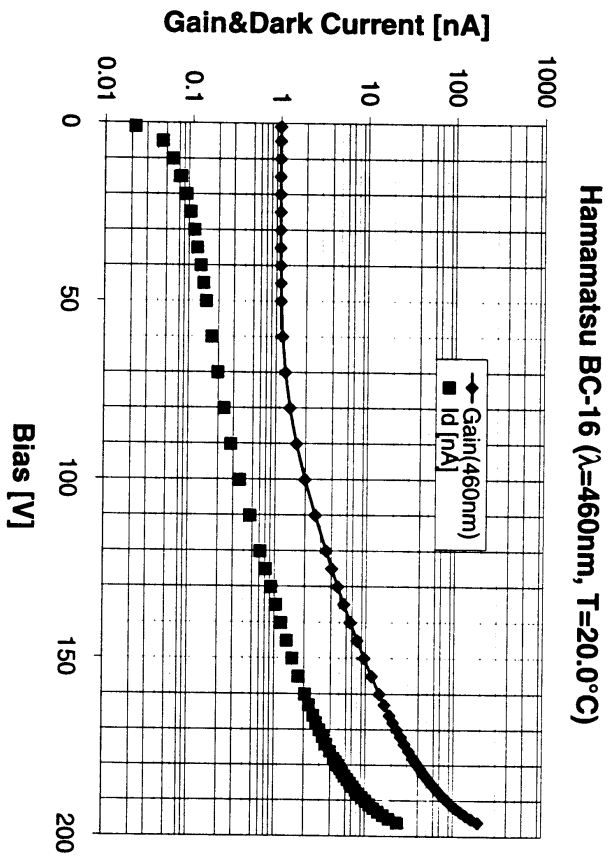


Figure 3: Gain and dark current as functions of bias voltage for Hamamatsu BC-16 APD measured before irradiation.

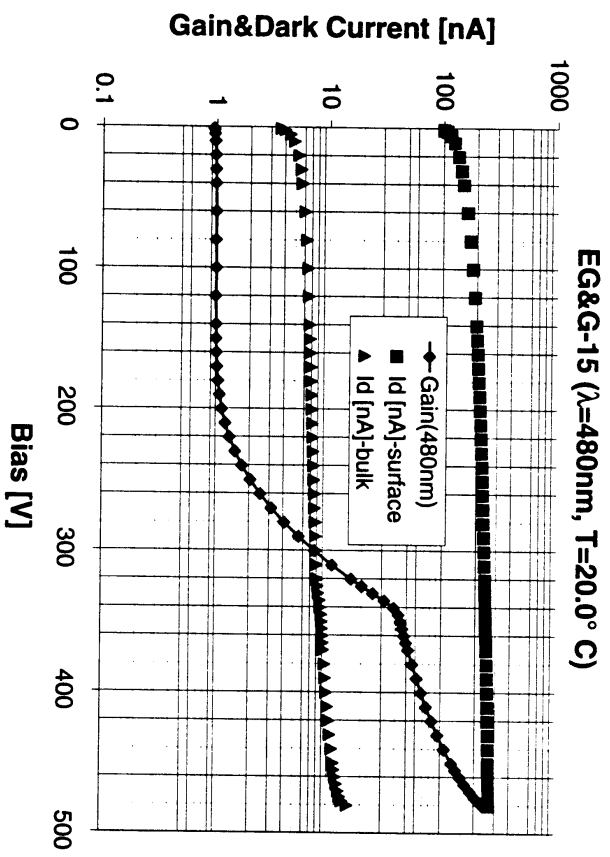


Figure 4: Gain and dark current as function of bias voltage for EG&G-15 APD measured before irradiation.

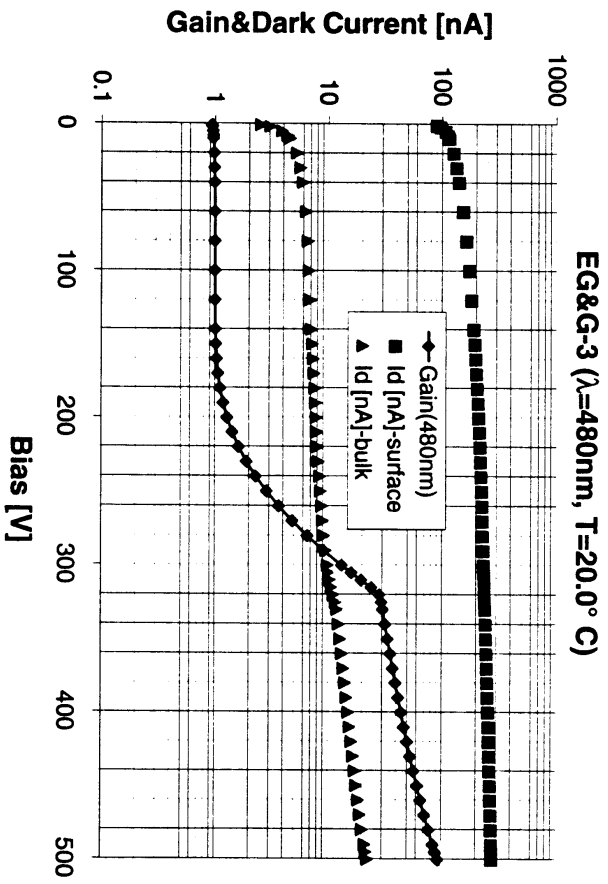


Figure 5: Gain and dark current as function of bias voltage for EG&G-3 APD measured before irradiation.

Conclusions

- Avalanche photodiodes are potentially attractive readout devices for next generation experiments
- They are no longer “exotic” (use in CMS as well as in telecommunications and PET scanners – expect prices to drop)
- Detailed studies may be needed, but manufacturers are used to dealing with HEP customers and eager to be involved in R&D